

Search Notes



Application/Control No.

10/668,673

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

TROCKI ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	93.01	3/20/2006	mlh.
	118		
	154		
	131		
	152		
	181		
	187		
	533		
	534		
	535		
600	431		
	432		
128	dig.1		
	dig.12		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	3/20/2006	mlh.
Inventor name search	3/20/2006	mlh.